

TYPES SN54LS112A, SN54S112, SN74LS112A, SN74S112 DUAL J-K NEGATIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

REVISED DECEMBER 1983

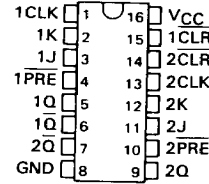
- Fully Buffered to Offer Maximum Isolation from External Disturbance
- Package Options Include Both Plastic and Ceramic Carriers in Addition to Plastic and Ceramic DIPs.
- Dependable Texas Instruments Quality and Reliability

description

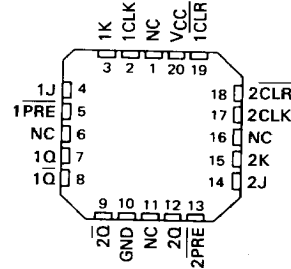
These devices contain two independent J-K negative-edge-triggered flip-flops. A low level at the preset or clear inputs sets or resets the outputs regardless of the levels of the other inputs. When preset and clear are inactive (high), data at the J and K inputs meeting the setup time requirements are transferred to the outputs on the negative-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold time interval, data at the J and K inputs may be changed without affecting the levels at the outputs. These versatile flip-flops can perform as toggle flip-flops by tying J and K high.

The SN54LS112A and SN54S112 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74LS112A and SN74S112 are characterized for operation from 0°C to 70°C.

SN54LS112A, SN54S112 ... J OR W PACKAGE
SN74LS112A, SN74S112 ... D, J OR N PACKAGE
(TOP VIEW)



SN54LS112A, SN54S112 ... FK PACKAGE
SN74LS112A, SN74S112 ... FN PACKAGE
(TOP VIEW)



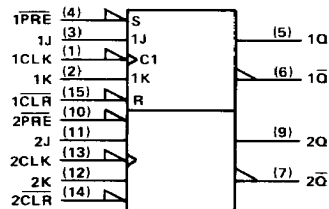
NC - No internal connection

FUNCTION TABLE (each flip-flop)

INPUTS					OUTPUTS	
PRE	CLR	CLK	J	K	Q	Q̄
L	H	X	X	X	H	L
H	L	X	X	X	L	H
L	L	X	X	X	H [†]	H [†]
H	H	↓	L	L	Q ₀	Q̄ ₀
H	H	↓	H	L	H	L
H	H	↓	L	H	L	H
H	H	↓	H	H	TOGGLE	TOGGLE
H	H	H	X	X	Q ₀	Q̄ ₀

[†] The output levels in this configuration are not guaranteed to meet the minimum levels for V_{OH} if the lows at preset and clear are near V_{IL} maximum. Furthermore, this configuration is nonstable; that is, it will not persist when either preset or clear returns to its inactive (high) level.

logic symbol



Pin numbers shown on logic notation are for D, J or N packages.

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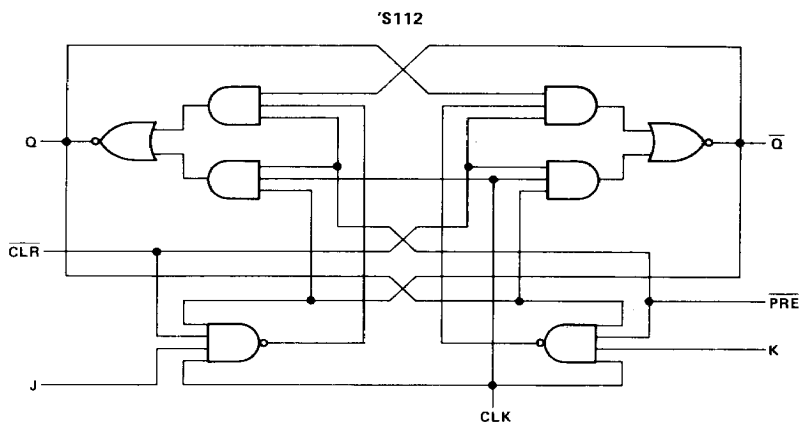
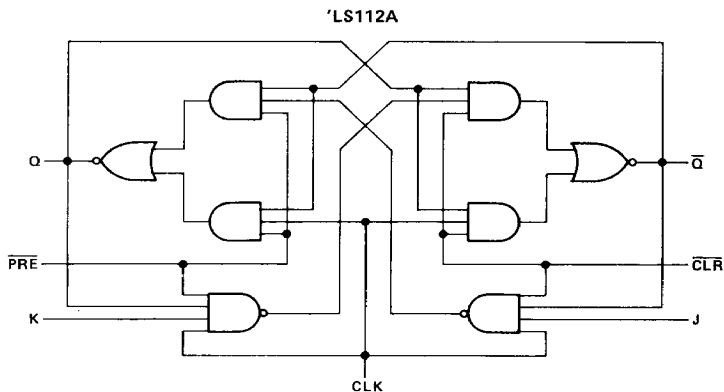
PRODUCTION DATA
This document contains information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

TEXAS
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TYPES SN54LS112A, SN54S112, SN74LS112A, SN74S112
DUAL J-K NEGATIVE-EDGE-TRIGGERED
FLIP-FLOPS WITH PRESET AND CLEAR

logic diagrams



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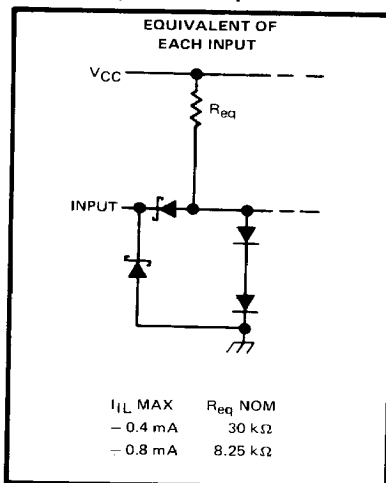
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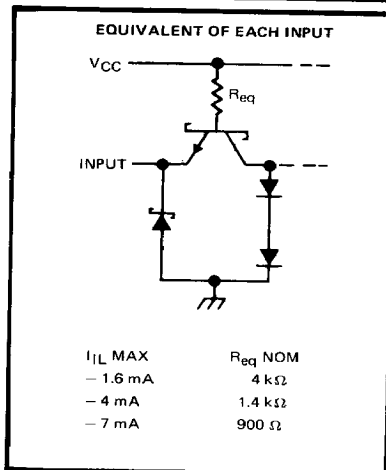
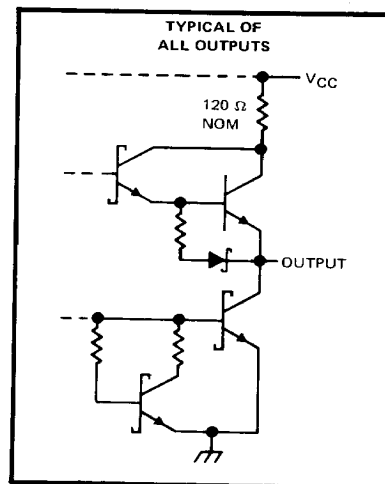
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TYPES SN54LS112A, SN54S112, SN74LS112A, SN74S112
DUAL J-K NEGATIVE-EDGE-TRIGGERED
FLIP-FLOPS WITH PRESET AND CLEAR

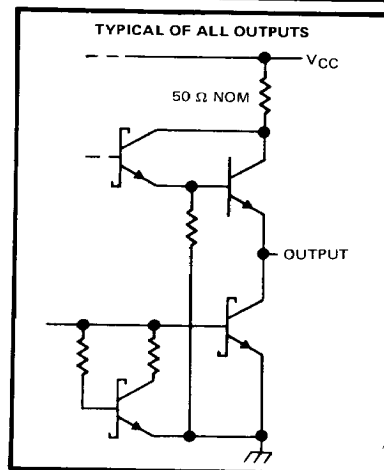
schematics of inputs and outputs



'LS112A



'S112



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage: 'LS112A	7 V
'S112	5.5 V
Operating free-air temperature range: SN54'	-55°C to 125°C
SN74'	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

TYPES SN54S112, SN74S112

DUAL J-K NEGATIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

recommended operating conditions

			SN54LS112A			SN74LS112A			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V _{IH}	High-level input voltage		2			2			V
V _{IL}	Low-level input voltage		0.7			0.8			V
I _{OH}	High-level output current		− 0.4			− 0.4			mA
I _{OL}	Low-level output current		4			8			mA
f _{clock}	Clock frequency		0		30		30		MHz
t _w	Pulse duration	CLK high	20			20			ns
		PRE or CLR low	25			25			
t _{su}	Setup time after CLK ↓	data high or low	20			20			ns
		CLR inactive	25			25			
		PRE inactive	20			20			
t _h	Hold time-data after CLK ↓		0			0			ns
T _A	Operating free-air temperature		− 55		125		70		°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		SN54LS112A			SN74LS112A			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V _{IK}		V _{CC} = MIN, I _I = - 18 mA		- 1.5			- 1.5			V
V _{OH}		V _{CC} = MIN, I _{OH} = - 0.4 mA	V _{IH} = 2 V, V _{IL} = MAX,	2.5	3.4		2.7	3.4		V
V _{OL}		V _{CC} = MIN, I _{OL} = 4 mA	V _{IL} = MAX, V _{IH} = 2 V,	0.25	0.4		0.25	0.4		V
		V _{CC} = MIN, I _{OL} = 8 mA	V _{IL} = MAX, V _{IH} = 2 V,				0.35	0.5		
I _I	J or K	V _{CC} = MAX, V _I = 7 V		0.1			0.1			mA
	CLR or PRE		0.3			0.3				
	CLK		0.4			0.4				
I _{IH}	J or K	V _{CC} = MAX, V _I = 2.7 V		20			20			μA
	CLR or PRE		60			60				
	CLK		80			80				
I _{IL}	J or K	V _{CC} = MAX, V _I = 0.4 V		- 0.4			- 0.4			mA
	All other		- 0.8			- 0.8				
I _{OS} §		V _{CC} = MAX, V _{CC} = MAX,	See Note 4 See Note 2	- 20	- 100		- 20	- 100		mA
I _{CC}				4	6		4	6		mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and $\bar{Q}$ outputs high in turn. At the time of measurement, the clock input is grounded.

NOTE 4: For certain devices where state commutation can be caused by shorting an output to ground, an equivalent test may be performed with V_O = 2.25 V and 2.125 V for the '54 family and the '74 family, respectively, with the minimum and maximum limits reduced to one half of their stated values.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
f _{max}			R _L = 2 kΩ, C _L = 15 pF		30	45		MHz
t _{PLH}	CLR, PRE or CLK	Q or Q̄			15	20		ns
t _{PHL}					15	20		ns

NOTE 3: See General Information Section for load circuits and voltage waveforms.

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TYPES SN54LS112A, SN74LS112A

DUAL J-K NEGATIVE-EDGE-TRIGGERED FLIP-FLOPS WITH PRESET AND CLEAR

recommended operating conditions

			SN54S112			SN74S112			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V _{IH}	High-level input voltage		2			2			V
V _{IL}	Low-level input voltage				0.8			0.8	V
I _{OH}	High-level output current				− 1			− 1	mA
I _{OL}	Low-level output current				20			20	mA
t _w	Pulse duration	CLK high	6			6			ns
		CLK low	6.5			6.5			
		PRE or CLR low	8			8			
t _{su}	Setup time before CLK ↓		data high or low			3			ns
t _h	Hold time-data after CLK ↓		0			0			ns
T _A	Operating free-air temperature		− 55			125			°C

electrical characteristics over recommended free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		SN54S112			SN74S112			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V _{IK}		V _{CC} = MIN, I _I = -18 mA				-1.2			-1.2	V
V _{OH}		V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V, I _{OH} = -1 mA		2.5	3.4		2.7	3.4		V
V _{OL}		V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V, I _{OL} = 20 mA				0.5			0.5	V
I _I		V _{CC} = MAX, V _I = 5.5 V				1			1	mA
I _{IH}	J or K	V _{CC} = MAX, V _I = 2.7 V				50			50	μA
	All other					100			100	
I _{IL}	J or K	V _{CC} = MAX, V _I = 0.5 V				-1.6			-1.6	mA
	CLR*					-7			-7	
	PRE*					-7			-7	
	CLK					-4			-4	
I _{OS} §		V _{CC} = MAX		-40		-100	-40		-100	mA
I _{CC}		V _{CC} = MAX, See Note 2			15	25		15	25	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

* Clear is tested with preset high and preset is tested with clear high.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and $\bar{Q}$ outputs high in turn. At the time of measurement, the clock input is grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
f _{max}					80	125		MHz
t _{PLH}	PRE or CLR	Q or $\bar{Q}$				4	7	ns
t _{PHL}	PRE or CLR (CLK high)	$\bar{Q}$ or Q				5	7	ns
	PRE or CLR (CLK low)					5	7	
t _{PLH}	CLK	Q or $\bar{Q}$	R _L = 280 Ω, C _L = 15 pF			4	7	ns
t _{PHL}						5	7	

NOTE 3: See General Information Section for load circuits and voltage waveforms.